

# **N-Channel Enhancement Mode MOSFET**

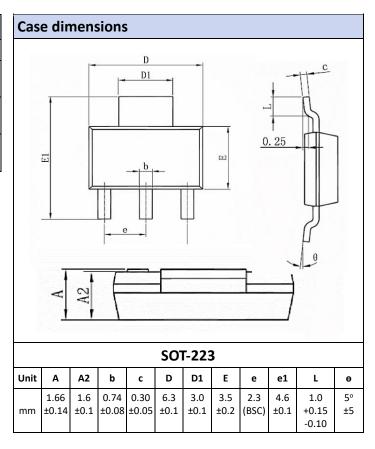
Primary characteristics				
Symbol	Parameter Value		Unit	
I <sub>D</sub>	Continuous drain current (@Tc=25°C)	10	Α	
V <sub>DS</sub>	Drain source voltage	60	V	
R <sub>DSON</sub> - typ(@V <sub>GS</sub> =10V)	Static drain-source on-resistance	<36 Typ. 28	mΩ	

## **Features**

- **SOT-223** case for easy automatic insertion
- Pb-free and RoHS compliant

# **Application**

- LED lamp
- Load switch
- Uninterruptible power supply



Maximum ratings (T <sub>C</sub> = 25°C)				
Characteristics	Symbol	Value	Unit	
Drain-source voltage	V <sub>DS</sub>	60	V	
Gate-source voltage	V <sub>GS</sub>	±20	V	
Continuous drain current, V <sub>GS</sub> @10V <sup>1</sup> @T <sub>C</sub> =25°C	I <sub>D</sub>	10	А	
Continuous drain current, V <sub>GS</sub> @10V <sup>1</sup> @T <sub>C</sub> =100°C	ID	8	А	
Pulsed drain current	I <sub>DM</sub>	30	А	
Single pulse avalanche energy	Eas	22	mJ	
Power Dissipation @T <sub>C</sub> =25°C	P <sub>D</sub>	31.3	W	
Operating junction temperature range	T <sub>J</sub> , T <sub>STG</sub>	-55 ~ 175	°C	
Thermal resistance junction-ambient <sup>1</sup>	R <sub>eJA</sub>	60	°C/W	
Thermal resistance junction-case <sup>1</sup>	R <sub>eJC</sub>	4	°C/W	

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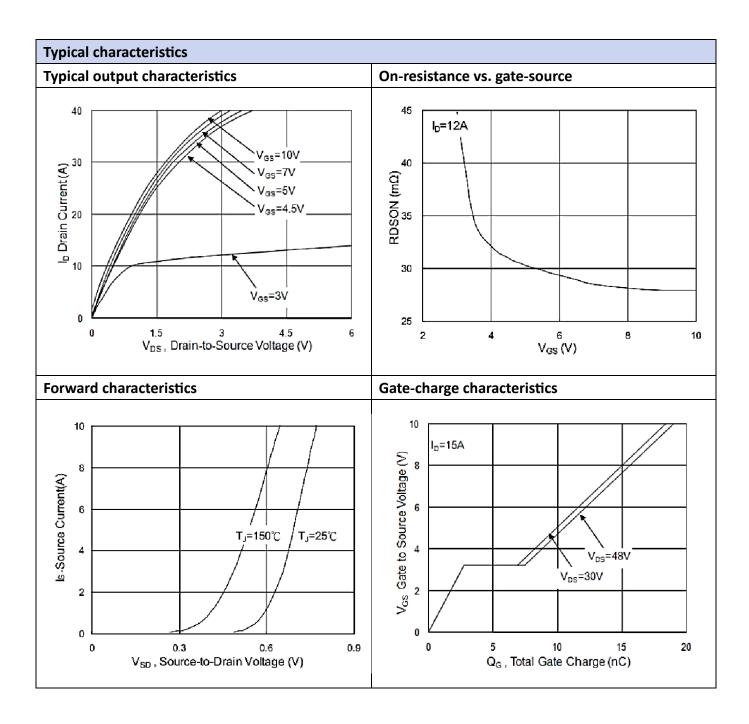


Maximum ratings (T <sub>C</sub> = 25°C)							
	To at a surdiate or	Complete al	Value				
Characteristics	Test condition	Symbol	Min.	Тур.	Max.	Unit	
Drain-source breakdown voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA	BV <sub>DSS</sub>	60	65	-	V	
BVDSS temperature coefficient	Reference to 25°C, I <sub>D</sub> =1mA	$\Delta BV_{DSS/\Delta TJ}$	-	0.044	-	V/°C	
Static drain-source on-resistance <sup>2</sup>	V <sub>GS</sub> =10V, I <sub>D</sub> =15A		-	28	36	mΩ	
	V <sub>GS</sub> =4.5V, I <sub>D</sub> =7A	R <sub>DS(ON)</sub>	-	38	45		
Gate-threshold voltage	V V 1 350::A	V <sub>GS(th)</sub>	1.2	1.6	2.5	V	
V <sub>GS</sub> (th) temperature coefficient	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA	$\Delta V_{GS(th)}$	-	-4.8	-	mV/°C	
Darin annual laska annual t	V <sub>DS</sub> =48V, V <sub>GS</sub> =0V, T <sub>J</sub> =25°C		-	-	1		
Drain-source leakage current	V <sub>DS</sub> =48V, V <sub>GS</sub> =0V, T <sub>J</sub> =55°C	I <sub>DSS</sub>	-	-	5	μΑ	
Gate-source leakage current	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V	I <sub>GSS</sub>	-	-	±100	nA	
Forward transconductance	V <sub>DS</sub> =5V, I <sub>D</sub> =15A	<b>g</b> FS	-	25.3	-	S	
Gate resistance	V <sub>DS</sub> =0V, V <sub>GS</sub> =0V, f=1MHz	Rg	-	2.5	-	Ω	
Total gate charge (10V)	V <sub>DS</sub> =48V	Qg	-	19	-	nC	
Gate-source charge	V <sub>GS</sub> =10V	Q <sub>gs</sub>	-	2.5	-		
Gate-drain charge	I <sub>D</sub> =15A	Q <sub>gd</sub>	-	5	-		
Turn-on delay time	V <sub>DD</sub> =30V	T <sub>d(on)</sub>	-	2.8	-		
Rise time	V <sub>GS</sub> =10V	T <sub>r</sub>	-	16.6	-	ns	
Turn-off delay time	$R_G=3.3\Omega$	t <sub>d(OFF)</sub>	-	21.2	-		
Fall time	I <sub>D</sub> =15A	t <sub>f</sub>	-	5.6	-		
Input capacitance	V <sub>DS</sub> =15V	Ciss	-	1027	-		
Output capacitance	V <sub>GS</sub> =0V	Coss	-	65	-	pF	
Reverse transfer capacitance	f=1.0MHz	C <sub>rss</sub>	-	46	-	1	
Continuous source current <sup>1, 6</sup>		Is	-	-	20	Α	
Pulsed source current <sup>2, 6</sup>	V <sub>G</sub> =V <sub>D</sub> =0V, force current	I <sub>SM</sub>	-	-	40	Α	
Diode forward voltage <sup>2</sup>	V <sub>GS</sub> =0V, I <sub>S</sub> =1A, T <sub>J</sub> =25°C	V <sub>SD</sub>	-	-	1.2	V	
Reverse recovery time	I <sub>F</sub> =15A , dI/dt=100A/μs ,	t <sub>rr</sub>	-	12.2	-	ns	
Reverse recovery charge	T <sub>J</sub> =25°C	Qrr	-	7.3	-	nC	

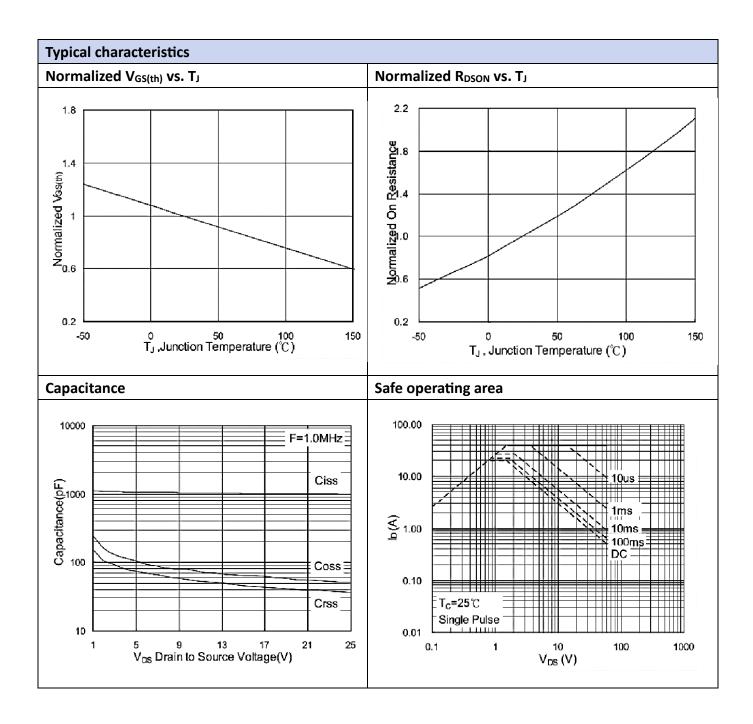
#### Note:

- 1. The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.
- 2. The data tested by pulsed, pulse width. The EAS data shows max. rating.
- 3. The test cond.  $\leq$  300 $\mu$ s duty cycle  $\leq$  2%, duty cycle is T<sub>J</sub> =25°C, V<sub>DD</sub> =48V, V<sub>G</sub> =10V, R<sub>G</sub> =25 $\Omega$ , L=0.1mH, I<sub>AS</sub> =13A.
- 4. The power dissipation is limited by 175°C junction temperature.
- 5. The data is theoretically the same as  $I_D$  and  $I_{DM}$ , in real applications, should be limited by total power dissipation.

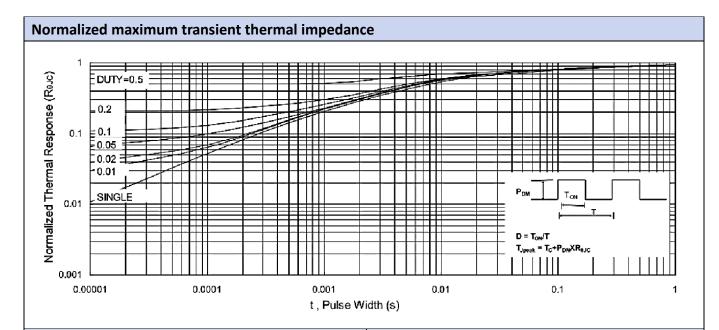




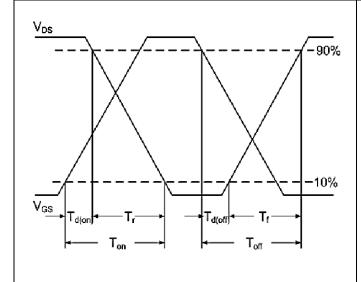




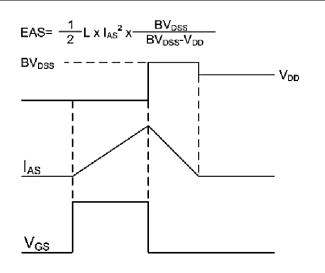




## Switching time waveform

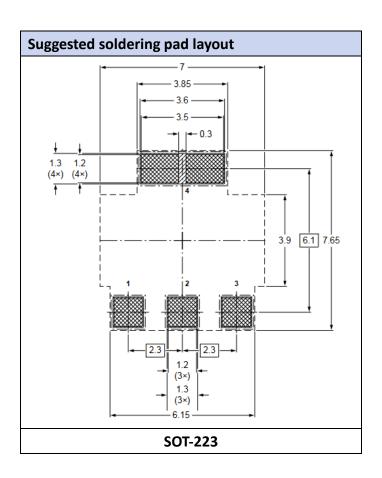


## **Unclamped inductive switching waveform**





Ordering information			
Part Number	Package	Shipping Quantity	Dimensions
10N06MSI	SOT-223	3000 pcs / reel	



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